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NBSIR 85-3029

METROLOGY FOR ELECTROMAGNETIC TECHNOLOGY: A BIBLIOGRAPHY OF NBS PUBLICATIONS

Edited by
Kathryn E. Kline
Mary E. DeWeese

National Bureau of Standards
U.S. Department of Commerce
Boulder, Colorado 80303

July 1985

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National Engineering Laboratory
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U.S. DEPARTMENT OF COMMERCE, Malcolm Baldrige, Secretary

NATIONAL BUREAU OF STANDARDS, Ernest Ambler, Director

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METROLOGY FOR ELECTROMAGNETIC TECHNOLOGY: A BIBLIOGRAPHY OF NBS PUBLICATIONS

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This bibliography lists the publications of the personnel of the Electromagnetic Technology Division of NBS in the period from January 1970 through December 1984. A few earlier references that are directly related to the present work of the Division are included.

Key words: cryoelectronics; electromagnetic metrology; lasers; microwaves; optical fibers; superconducting materials; time domain metrology.

INTRODUCTION

The Electromagnetic Technology Division was formed during the reorganization of NBS in April 1978 by combining parts of the former Electromagnetics and Cryogenics Divisions. It develops measurement methods and standards and provides metrological support for: laser systems, optical communication equipment, cryoelectronics, superconductors, and other unusual electrical engineering materials. For the individual staff members of the division, the reorganization brought a realignment of long-term goals but little immediate discontinuity in their work. It therefore makes good sense that this bibliography should cover a period beginning some time before the reorganization, so as to include at least the more recent origins of the present work of the division. The editors have attempted to include all work published by the present staff members of the division, while they were employees of NBS, in the period from January 1970 to December 1984. There are a few exceptions, where work that is totally unrelated to the present program has been excluded or where work by authors now in other parts of NBS has been included because of its special significance. The work on electromagnetic waveform metrology was moved to another part of the organization in October 1982 and was followed by the transfer of the work on microwave metrology in April 1985. Papers submitted prior to those dates are included, but later publications are not. A few papers on various topics published before 1970 have also been included because of their direct relationship to the present program.

There are several other sources that may be useful to the reader who is interested in activities at NBS connected with electromagnetic metrology. Companion bibliographies to this one list the publications of the Electromagnetic Fields Division: NBSIR 80-1635, NBSIR 82-1673, and NBSIR 85-3022. Their topics include metrology for antennas, satellite communications equipment, electromagnetic interference, and hazard. Three bibliographies of the publications of the former Electromagnetics Division have been published:

NBSIR 73-820 (July 1972-June 1973); NBSIR 74-395 (July 1973-June 1974); NBSIR 75-818 (July 1974-June 1975). These were preceded by a series of unpublished reports (edited by H. M. Altschuler) that cover the period back to 1956. An excellent summary of the whole field of electromagnetic metrology as it stood in 1967 was published as a special issue of the IEEE Proceedings (vol. 55; June 1967). Advances in the following decade were described in another special issue of the same journal (vol. 66; April 1978).

A Note on Abbreviations

Most readers will be familiar with the commonly used abbreviations for the names of the various professional journals that appear in this bibliography. There are also some publication series that are peculiar to NBS and may call for explanation. They are:

NBSIR - NBS Interagency/Internal Report
NBS TN - NBS Technical Note
NBS SP - NBS Special Publication
NBS HB - NBS Handbook
NBS JRES - NBS Journal of Research
NBS MN - NBS Monograph

Purchase Procedures and Document Availability

NBS Technical Notes, Special Publications, Handbooks, Journals of Research, and Monographs may be purchased from the Superintendent of Documents, U.S. Government Printing Office, Washington, DC 20402. Orders must be accompanied by postal money order, express money order, or check made out to the Superintendent of Documents.

NBS Interagency/Internal Reports (NBSIRs) may be purchased from the National Technical Information Service, Springfield, VA 22161. Orders must be accompanied by postal money order, express money order, or check made out to the NTIS.

Reprints of papers published in non-NBS media may be available in limited quantities from the authors.

Acknowledgments

A large part of the labor of preparing a bibliography is spent on collecting and arranging the material. We thank Frances Brown, Jessie Page, and Sheila Aaker for their assistance with these chores. The prime source of material was the NTIS file, with access through the Lockheed Dialog System. This was supplemented with material supplied by the individual authors.

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NBS-114A (REV. 2-8C)

U.S. DEPT. OF COMM. BIBLIOGRAPHIC DATA SHEET (See instructions)	1. PUBLICATION OR REPORT NO. NBSIR 85-3029	2. Performing Organ. Report No.	3. Publication Date July 1985

4. TITLE AND SUBTITLE

Metrology for Electromagnetic Technology:
A Bibliography of NBS Publications

5. AUTHOR(S)
Kathryn E. Kline and Mary E. DeWeese, eds.

6. PERFORMING ORGANIZATION (If joint or other than NBS, see instructions)

NATIONAL BUREAU OF STANDARDS
DEPARTMENT OF COMMERCE
WASHINGTON, D.C. 20234

7. Contract/Grant No.

8. Type of Report & Period Covered
NBSIR 1/1970-12/1984

9. SPONSORING ORGANIZATION NAME AND COMPLETE ADDRESS (Street, City, State, ZIP)

10. SUPPLEMENTARY NOTES

Updates and supersedes NBSIR 82-1677 and NBSIR 84-3014.

☐ Document describes a computer program; SF-185, FIPS Software Summary, is attached.

11. ABSTRACT (A 200-word or less factual summary of most significant information. If document includes a significant bibliography or literature survey, mention it here)

This bibliography lists the publications of the personnel of the Electromagnetic Technology Division of NBS in the period from January 1970 through December 1984. A few earlier references that are directly related to the present work of the Division are included.

12. KEY WORDS (Six to twelve entries; alphabetical order; capitalize only proper names; and separate key words by semicolons)

cryoelectronics; electromagnetic metrology; lasers; microwaves; optical fibers; superconducting materials; time domain metrology.

13. AVAILABILITY

☒ Unlimited
☐ For Official Distribution. Do Not Release to NTIS
☐ Order From Superintendent of Documents, U.S. Government Printing Office, Washington, D.C. 20402.
☒ Order From National Technical Information Service (NTIS), Springfield, VA. 22161

14. NO. OF PRINTED PAGES
72

15. Price

☆ U.S. GOVERNMENT PRINTING OFFICE: 1985--579-842 / 25298

USCOMM-DC 6043-P80